Document Title

256Kx16 bit Low Power and Low Voltage CMOS Static RAM

Revision History

Revision No	<u>History</u>	<u>Draft Date</u>	<u>Remark</u>
0.0	Initial draft	July 29, 2002	Preliminary
0.1	Revised - Added Commercial product - Deleted 44-TSOP2-400R Package Type Added 55ns product(@ 3.0V~3.6V)	December 2, 2002	Preliminary
1.0	Finalized - Changed Icc(Operating power supply current) from 4mA to 2mA - Changed Icc1(Average operating current) from 4mA to 3mA - Changed Icc2(Average operating current) from 40mA to 25mA - Changed Isв1(Standby Current(CMOS), Commercial) from 15μA to 10μA - Changed Isв1(Standby Current(CMOS), Industrial) from 20μA to 10μA - Changed Isв1(Standby Current(CMOS), Automotive) from 30μA to 20μA - Changed IbR(Data retention current, Commercial) from 15μA to 10μA - Changed IbR(Data retention current, Industrial) from 20μA to 10μA - Changed IDR(Data retention current, Automotive) from 30μA to 20μA	August 8, 2003	Final
2.0	Revised - Changed Isв1 of Automotive product from 20μA to 30μA - Changed IDR of Automotive product from 20μA to 30μA - Added Lead Free Products	March 27, 2005	Final

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256Kx16 bit Low Power and Low Voltage CMOS Static RAM

FEATURES

- Process Technology: Full CMOS
- Organization: 256K x16
- Power Supply Voltage: 2.7~3.6V
- Low Data Retention Voltage: 2V(Min)
- Three State Outputs
- Package Type: 44-TSOP2-400F

GENERAL DESCRIPTION

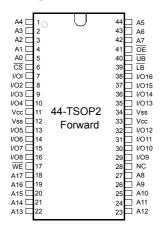
The K6X4016T3F families are fabricated by SAMSUNG's advanced CMOS process technology. The families support various operating temperature range and have 44-TSOP2 package type for user flexibility of system design. The families also support low data retention voltage for battery back-up operation with low data retention current.

PRODUCT FAMILY

				Power Di	ssipation		
Product Family	Operating Temperature	Vcc Range	Speed(ns)	Standby (IsB1, Max)	Operating (Icc2, Max)	PKG Type	
K6X4016T3F-B	Commercial(0~70°C)		55 ¹⁾ /70 ²⁾ /85ns	10μΑ			
K6X4016T3F-F	Industrial(-40~85°C)	2.7~3.6V	33 710 703113	10μΑ	25mA	44-TSOP2-400F	
K6X4016T3F-Q	Automotive(-40~125°C)		70 ²⁾ /85ns	30μΑ			

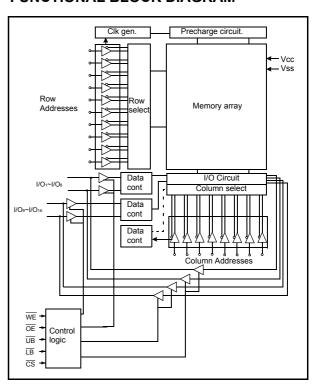
^{1.} This parameter is measured with 30pF test load (Vcc=3.0~3.6V).

PIN DESCRIPTION



Name	Function	Name	Function
CS	Chip Select Input	Vcc	Power
ŌĒ	Output Enable Input	Vss	Ground
WE	Write Enable Input	LB	Lower Byte (I/O1~8)
A0~A17	Address Inputs	UB	Upper Byte (I/O9~16)
I/O1~I/O16	Data Input/Output	NC	No Connection

FUNCTIONAL BLOCK DIAGRAM



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^{2.} The parameter is measured with 30pF test load.

PRODUCT LIST

Commercial Products(0~70°C)		Industrial Pro	ducts(-40~85°C)	Automotive Products(-40~125°C)			
Part Name	Function Part Name		Function	Part Name	Function		
K6X4016T3F-TB70	44-TSOP2-F, 55ns, LL 44-TSOP2-F, 70ns, LL 44-TSOP2-F, 85ns, LL 44-TSOP2-F, 55ns, LL, LF 44-TSOP2-F, 70ns, LL, LF 44-TSOP2-F, 85ns, LL, LF	K6X4016T3F-TF70	44-TSOP2-F, 55ns, LL 44-TSOP2-F, 70ns, LL 44-TSOP2-F, 85ns, LL 44-TSOP2-F, 55ns, LL, LF 44-TSOP2-F, 70ns, LL, LF 44-TSOP2-F, 85ns, LL, LF	K6X4016T3F-TQ85 K6X4016T3F-UQ70	44-TSOP2-F, 70ns, L 44-TSOP2-F, 85ns, L 44-TSOP2-F, 70ns, L, LF 44-TSOP2-F, 85ns, L, LF		

Operating voltage range is 3.0~3.6V
 LF: Lead Free Product

FUNCTIONAL DESCRIPTION

CS	OE	WE	LB	UB	I/O1~8	I/O9~16	Mode	Power
Н	X ¹⁾	X ¹⁾	X ¹⁾	X ¹⁾	High-Z	High-Z	Deselected	Standby
L	Н	Н	X ¹⁾	X ¹⁾	High-Z	High-Z	Output Disabled	Active
L	X ¹⁾	X ¹⁾	Н	Н	High-Z	High-Z	Output Disabled	Active
L	L	Н	L	Н	Dout	High-Z	Lower Byte Read	Active
L	L	Н	Н	L	High-Z	Dout	Upper Byte Read	Active
L	L	Н	L	L	Dout	Dout	Word Read	Active
L	X ¹⁾	L	L	Н	Din	High-Z	Lower Byte Write	Active
L	X ¹⁾	L	Н	L	High-Z	Din	Upper Byte Write	Active
L	X ¹⁾	L	L	L	Din	Din	Word Write	Active

^{1.} X means don't care. (Must be in low or high state)

ABSOLUTE MAXIMUM RATINGS1)

Item	Symbol	Ratings	Unit	Remark
Voltage on any pin relative to Vss	VIN, VOUT	-0.2 to Vcc+0.3(max. 3.9V)	V	-
Voltage on Vcc supply relative to Vss	Vcc	-0.2 to 3.9	V	-
Power Dissipation	PD	1.0	W	-
Storage temperature	Тѕтс	-65 to 150	°C	-
		0 to 70		K6X4016T3F-B
Operating Temperature	TA	-40 to 85	°C	K6X4016T3F-F
		-40 to 125	1	K6X4016T3F-Q

^{1.} Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Functional operation should be restricted to recommended operating condition. Exposure to absolute maximum rating conditions for extended periods may affect reliability.



RECOMMENDED DC OPERATING CONDITIONS¹⁾

ltem	Symbol	Min	Тур	Max	Unit
Supply voltage	Vcc	2.7	3.0/3.3	3.6	V
Ground	Vss	0	0	0	V
Input high voltage	VIH	2.2	-	Vcc+0.2 ²⁾	V
Input low voltage	VIL	-0.2 ³⁾	-	0.6	V

- 1. Commercial Product: T_A=0 to 70°C, otherwise specified. Industrial Product: Ta=-40 to 85°C, otherwise specified. Automotive Product: Ta=-40 to 125°C, otherwise specified.
- 2. Overshoot: Vcc+2.0V in case of pulse width \leq 30ns.
- 3. Undershoot: -2.0V in case of pulse width ≤ 30ns.
 4. Overshoot and undershoot are sampled, not 100% tested.

CAPACITANCE¹⁾ (f=1MHz, TA=25°C)

Item	Symbol	Test Condition	Min	Max	Unit
Input capacitance	Cin	VIN=0V	-	8	pF
Input/Output capacitance	Сю	Vio=0V	-	10	pF

^{1.} Capacitance is sampled, not 100% tested

DC AND OPERATING CHARACTERISTICS

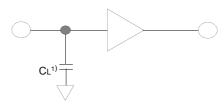
Item	Symbol	Test Conditi	ons	Min	Тур	Max	Unit
Input leakage current	ILI	VIL=Vss to Vcc	VIL=Vss to Vcc			1	μΑ
Output leakage current	llo	CS=VIH or OE=VIH or WE=VIL VIC	CS=VIH or OE=VIH or WE=VIL VIO=Vss to Vcc			1	μА
Operating power supply current	Icc	IIO=0mA, CS=VIL, VIN=VIL or VIH,	Read	-	-	2	mA
Average operating current	Icc1	Cycle time=1µs, 100% duty, lio=0 Vin≤0.2V or Vin≥Vcc-0.2V	mA CS ≤0.2V,	-	-	3	mA
Average operating current	ICC2	Cycle time=Min²), 100% duty, Iıo=0mA, $\overline{\text{CS}}$ =VıL, Vın=VıH or VıL		-	-	25	mA
Output low voltage	Vol	IoL=2.1mA		-	-	0.4	V
Output high voltage	Vон	Iон=-1.0mA		2.4	-	-	V
Standby Current(TTL)	Isb	СS=VIH, Other inputs=VIL or VIH		-	-	0.3	mA
			K6X4016T3F-B	-	-	10	μА
Standby Current(CMOS)	ISB1	CS≥Vcc-0.2V, Other inputs=0~Vcc	K6X4016T3F-F	-	-	10	μА
		r	K6X4016T3F-Q	-	-	30	μА



AC OPERATING CONDITIONS

TEST CONDITIONS (Test Load and Input/Output Reference)

Input pulse level: 0.4 to 2.2V
Input rising and falling time: 5ns
Input and output reference voltage: 1.5V
Output load(see right): CL=100pF+1TTL
CL=30pF+1TTL



1.Including scope and jig capacitance

AC CHARACTERISTICS

(Vcc=2.7~3.6V, Commercial product: Ta=0 to 70°C, Industrial product: Ta=-40 to 85°C, Automotive product: Ta=-40 to 125°C)

	Parameter List				Spee	d Bins			
			55	ns¹)	70	ns	85	ins	Units
			Min	Max	Min	Max	Min	Max	
	Read cycle time	trc	55	-	70	-	85	-	ns
	Address access time	taa	-	55	-	70	-	85	ns
	Chip select to output	tco	-	55	-	70	-	85	ns
	Output enable to valid output	toE	-	25	-	35	-	40	ns
	LB, UB valid to data output	tва	-	25	-	35	-	40	ns
Read	Chip select to low-Z output	tız	10	-	10	-	10	-	ns
Read	Output enable to low-Z output	tolz	5	-	5	-	5	-	ns
	LB, UB enable to low-Z output	tBLZ	5	-	5	-	5	-	ns
	Output hold from address change	tон	10	-	10	-	10	-	ns
	Chip disable to high-Z output	tHZ	0	20	0	25	0	25	ns
	OE disable to high-Z output	tонz	0	20	0	25	0	25	ns
	LB, UB disable to high-Z output	tвнz	0	20	0	25	0	25	ns
	Write cycle time	twc	55	-	70	-	85	-	ns
	Chip select to end of write	tcw	45	-	60	-	70	-	ns
	Address set-up time	tas	0	-	0	-	0	-	ns
	Address valid to end of write	taw	45	-	60	-	70	-	ns
	Write pulse width	twp	40	-	55	-	60	-	ns
Write	Write recovery time	twr	0	-	0	-	0	-	ns
	Write to output high-Z	twnz	0	20	0	25	0	25	ns
	Data to write time overlap	tow	25	-	30	-	35	-	ns
	Data hold from write time	tон	0	-	0	-	0	-	ns
	End write to output low-Z	tow	5	-	5	-	5	-	ns
	LB, UB valid to end of write	tвw	45	-	60	-	70	-	ns

^{1.} Voltage range is 3.0V~3.6V for commercial and industrial product.

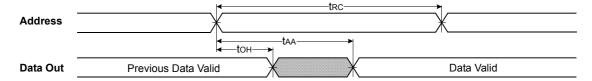
DATA RETENTION CHARACTERISTICS

Item	Symbol	Test Condition			Тур	Max	Unit
Vcc for data retention	VDR	CS ≥Vcc-0.2V	2.0	-	3.6	V	
Data retention current			K6X4016T3F-B		-	10	μΑ
	IDR	Vcc=3.0V, CS ≥Vcc-0.2V	K6X4016T3F-F	-		10	μΑ
		K6X4016T3F-Q				30	μΑ
Data retention set-up time	tsdr	See data retention waveform		0	-	-	ms
Recovery time	trdr	See data retention wavelonn		5	1	-	1115

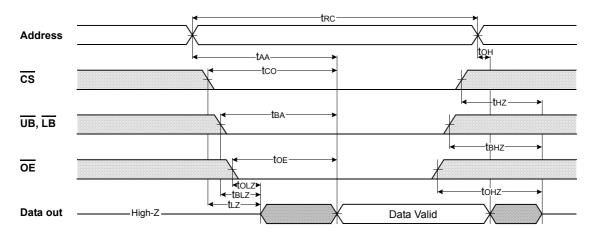


TIMING DIAGRAMS

TIMING WAVEFORM OF READ CYCLE(1) (Address Controlled, $\overline{CS} = \overline{OE} = VIL$, $\overline{WE} = VIH$, \overline{UB} or/and $\overline{LB} = VIL$)



TIMING WAVEFORM OF READ CYCLE(2) (WE=VIH)

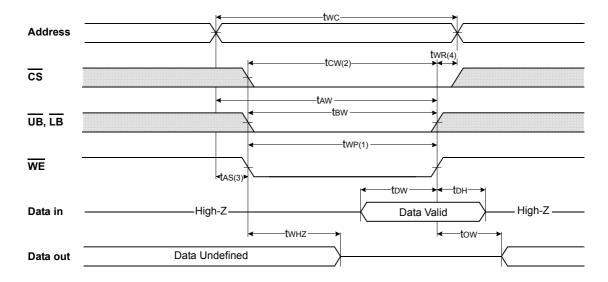


NOTES (READ CYCLE)

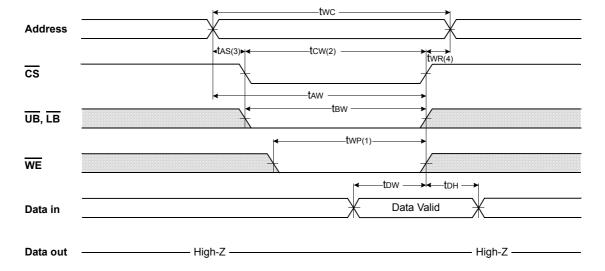
- 1. tHZ and tOHZ are defined as the time at which the outputs achieve the open circuit conditions and are not referenced to output voltage
- 2. At any given temperature and voltage condition, tHZ(Max.) is less than tLZ(Min.) both for a given device and from device to device interconnection.



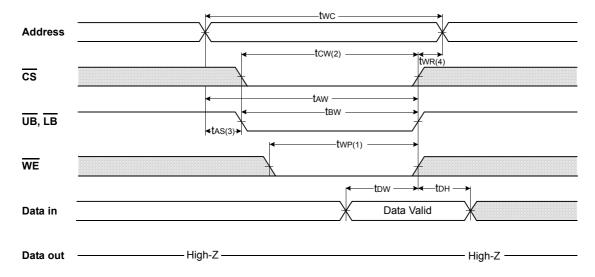
TIMING WAVEFORM OF WRITE CYCLE(1) (WE Controlled)



TIMING WAVEFORM OF WRITE CYCLE(2) (CS Controlled)



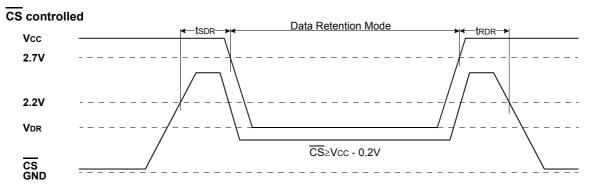
TIMING WAVEFORM OF WRITE CYCLE(3) (UB, LB Controlled)



NOTES (WRITE CYCLE)

- 1. A write occurs during the overlap(twr) of low \overline{CS} and low \overline{WE} . A write begins when \overline{CS} goes low and \overline{WE} goes low with asserting \overline{UB} or \overline{LB} for single byte operation or simultaneously asserting \overline{UB} and \overline{LB} for double byte operation. A write ends at the earliest transition when \overline{CS} goes high and \overline{WE} goes high. The twp is measured from the beginning of write to the end of write.
- 2. tcw is measured from the $\overline{\text{CS}}$ going low to the end of write.
- 3. tas is measured from the address valid to the beginning of write.
- 4. twn is measured from the end of write to the address change. twn is applied in case a write ends with $\overline{\text{CS}}$ or $\overline{\text{WE}}$ going high.

DATA RETENTION WAVE FORM





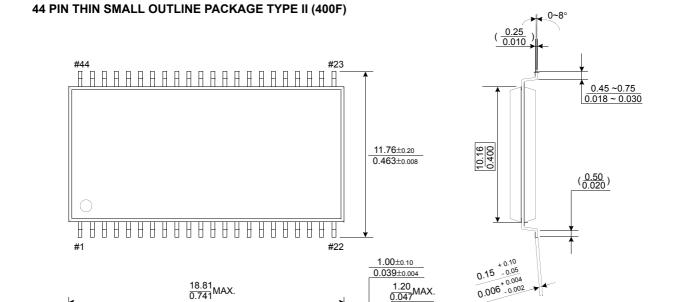
18.41±0.10 0.725±0.004

0.35±0.10 0.014±0.004

PACKAGE DIMENSIONS

(0.805)

Unit: millimeter(inch)



0.05 0.002 MIN. $\frac{0.10}{0.004}$ MAX

